

VE320 Homework Four

Due: 2021/6/14 23:59

- (a) The required conductivity of an n-type silicon sample at $T = 300\text{ K}$ is to be $\sigma = 10(\Omega \cdot \text{cm})^{-1}$. What donor impurity concentration is required? What is the electron mobility corresponding to this impurity concentration?

(b) A p-type silicon material is required to have a resistivity of $\rho = 0.20(\Omega \cdot \text{cm})$. What acceptor impurity concentration is required and what is the corresponding hole mobility?
- A perfectly compensated semiconductor is one in which the donor and acceptor impurity concentrations are exactly equal. Assuming complete ionization, determine the resistivity of silicon at $T = 300\text{ K}$ in which the impurity concentrations are

(a) $N_a = N_d = 10^{14}\text{ cm}^{-3}$

(b) $N_a = N_d = 10^{16}\text{ cm}^{-3}$

(c) $N_a = N_d = 10^{18}\text{ cm}^{-3}$
- Consider a semiconductor that is uniformly doped with $N_d = 10^{14}\text{ cm}^{-3}$ and $N_a = 0$, with an applied electric field of $E = 100\text{ V/cm}$. Assume that $\mu_n = 1000\text{ cm}^2/\text{V} \cdot \text{s}$ and $\mu_p = 0$. Also assume the following parameters:

$$N_c = 2 \times 10^{19} \left(\frac{T}{300}\right)^{\frac{3}{2}} \text{ cm}^{-3}, N_v = 1 \times 10^{19} \left(\frac{T}{300}\right)^{\frac{3}{2}} \text{ cm}^{-3}, E_g = 1.10\text{ eV}$$

(a) Calculate the electric-current density at $T = 300\text{ K}$.

(b) At what temperature will this current increase by 5 percent? (Assume the mobilities are independent of temperature.)
- The effective density of states functions in silicon can be written in the form

$$N_c = 2.8 \times 10^{19} \left(\frac{T}{300}\right)^{\frac{3}{2}}, N_v = 1.04 \times 10^{19} \left(\frac{T}{300}\right)^{\frac{3}{2}}$$

Assume the mobilities are given by

$$\mu_n = 1350 \left(\frac{T}{300}\right)^{\frac{3}{2}}, \mu_p = 480 \left(\frac{T}{300}\right)^{\frac{3}{2}}$$

Assume the bandgap energy is $E_g = 1.12\text{ eV}$ and independent of temperature. **Plot** the intrinsic conductivity as a function of T over the range $200 \leq T \leq 600\text{ K}$.
- The steady-state electron distribution in silicon can be approximated by a linear function of x . The maximum electron concentration occurs at $x = 0$ and is $n(0) = 2 \times 10^{16}\text{ cm}^{-3}$. At $x = 0.012\text{ cm}$, the electron concentration is 5×10^{15} . If the electron diffusion coefficient is $D_n = 27\text{ cm}^2/\text{s}$, determine the electron diffusion current density.
- Consider an n-type semiconductor at $T = 300\text{ K}$ in thermal equilibrium (no current). Assume that the donor concentration varies as $N_d(x) = N_{d0}e^{-\frac{x}{L}}$ over the range $0 \leq x \leq L$ where $N_{d0} = 10^{16}\text{ cm}^{-3}$ and $L = 10\mu\text{m}$.

(a) Determine the electric field as a function of x for $0 \leq x \leq L$.

(b) Calculate the potential difference between $x = 0$ and $x = L$ (with the potential at $x = 0$ being positive with respect to that at $x = L$).